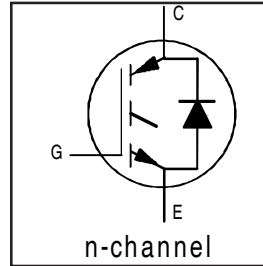


# IRG4PC50UDPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE UltraFast CoPack IGBT

## Features

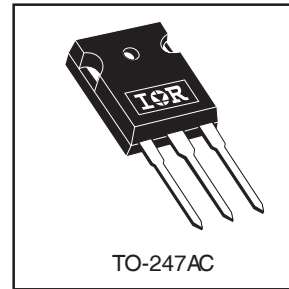
- UltraFast: Optimized for high operating frequencies 8-40 kHz in hard switching, >200 kHz in resonant mode
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package
- Lead-Free



|                             |
|-----------------------------|
| $V_{CES} = 600V$            |
| $V_{CE(on) typ.} = 1.65V$   |
| @ $V_{GE} = 15V, I_C = 27A$ |

## Benefits

- Generation 4 IGBT's offer highest efficiencies available
- IGBT's optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's



## Absolute Maximum Ratings

|                           | Parameter                          | Max.                              | Units |
|---------------------------|------------------------------------|-----------------------------------|-------|
| $V_{CES}$                 | Collector-to-Emitter Voltage       | 600                               | V     |
| $I_C @ T_C = 25^\circ C$  | Continuous Collector Current       | 55                                | A     |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current       | 27                                |       |
| $I_{CM}$                  | Pulsed Collector Current ①         | 220                               |       |
| $I_{LM}$                  | Clamped Inductive Load Current ②   | 220                               |       |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current   | 25                                |       |
| $I_{FM}$                  | Diode Maximum Forward Current      | 220                               |       |
| $V_{GE}$                  | Gate-to-Emitter Voltage            | $\pm 20$                          | V     |
| $P_D @ T_C = 25^\circ C$  | Maximum Power Dissipation          | 200                               | W     |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation          | 78                                |       |
| $T_J$                     | Operating Junction and             | -55 to +150                       | °C    |
| $T_{STG}$                 | Storage Temperature Range          |                                   |       |
|                           | Soldering Temperature, for 10 sec. | 300 (0.063 in. (1.6mm) from case) |       |
|                           | Mounting Torque, 6-32 or M3 Screw. | 10 lbf•in (1.1 N•m)               |       |

## Thermal Resistance

|                 | Parameter                                 | Min.  | Typ.     | Max.  | Units  |
|-----------------|---|-------|----------|-------|--------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT                   | ----- | -----    | 0.64  | °C/W   |
| $R_{\theta JC}$ | Junction-to-Case - Diode                  | ----- | -----    | 0.83  |        |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface       | ----- | 0.24     | ----- |        |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | ----- | -----    | 40    |        |
| Wt              | Weight                                    | ----- | 6 (0.21) | ----- | g (oz) |

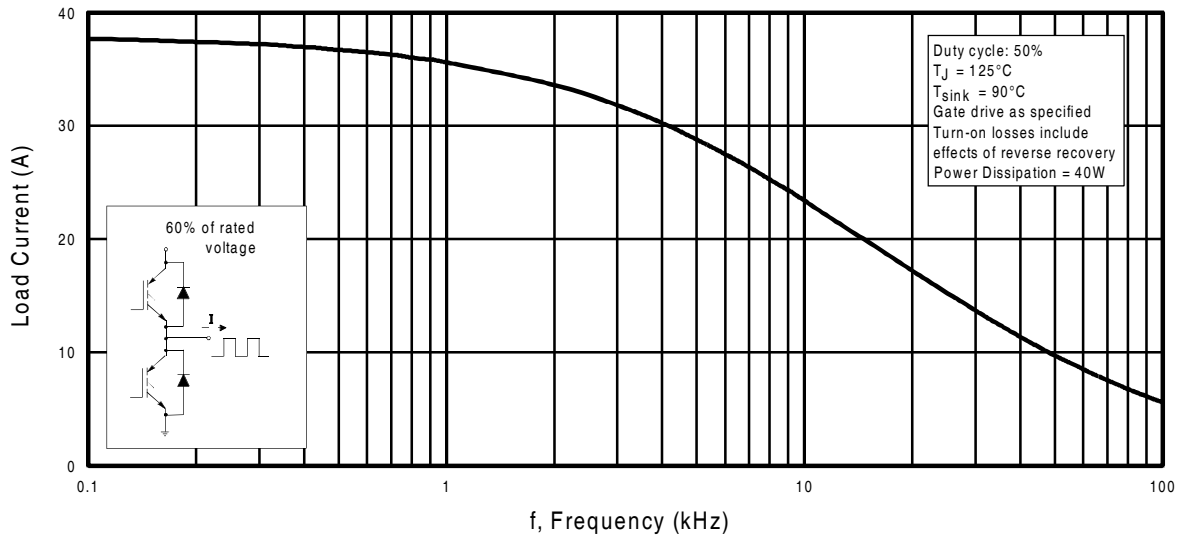
# IRG4PC50UDPbF

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

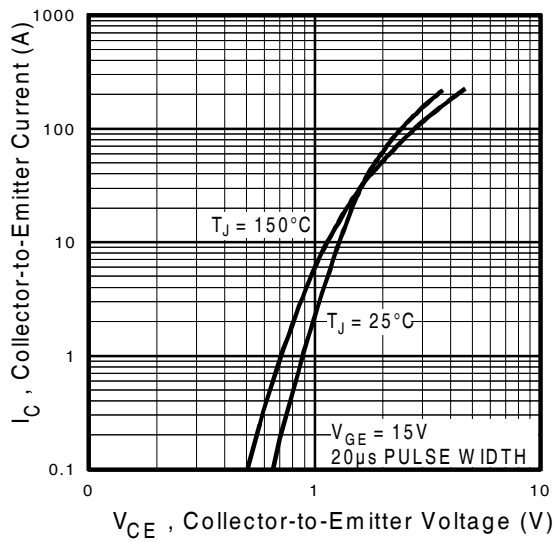
|  | Parameter   | Min. | Typ. | Max. | Units | Conditions   |
|--|---|------|------|------|-------|--|
| V <sub>(BR)CES</sub>                   | Collector-to-Emitter Breakdown Voltage <sup>③</sup> | 600  | ---- | ---- | V     | V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA   |
| ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub> | Temperature Coeff. of Breakdown Voltage             | ---- | 0.60 | ---- | V/°C  | V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0mA   |
| V <sub>CE(on)</sub>                    | Collector-to-Emitter Saturation Voltage             | ---- | 1.65 | 2.0  | V     | I <sub>C</sub> = 27A<br>I <sub>C</sub> = 55A<br>I <sub>C</sub> = 27A, T <sub>J</sub> = 150°C<br>V <sub>GE</sub> = 15V<br>See Fig. 2, 5 |
|  |   | ---- | 2.0  | ---- |       |  |
|  |   | ---- | 1.6  | ---- |       |  |
| V <sub>GE(th)</sub>                    | Gate Threshold Voltage                              | 3.0  | ---- | 6.0  |       | V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA   |
| ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>  | Temperature Coeff. of Threshold Voltage             | ---- | -13  | ---- | mV/°C | V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA   |
| g <sub>fe</sub>                        | Forward Transconductance <sup>④</sup>               | 16   | 24   | ---- | S     | V <sub>CE</sub> = 100V, I <sub>C</sub> = 27A   |
| I <sub>CES</sub>                       | Zero Gate Voltage Collector Current                 | ---- | ---- | 250  | μA    | V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V<br>V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V, T <sub>J</sub> = 150°C                   |
|  |   | ---- | ---- | 6500 |       |  |
| V <sub>FM</sub>                        | Diode Forward Voltage Drop                          | ---- | 1.3  | 1.7  | V     | I <sub>C</sub> = 25A<br>I <sub>C</sub> = 25A, T <sub>J</sub> = 150°C<br>See Fig. 13  |
|  |   | ---- | 1.2  | 1.5  |       |  |
| I <sub>GES</sub>                       | Gate-to-Emitter Leakage Current                     | ---- | ---- | ±100 | nA    | V <sub>GE</sub> = ±20V   |

## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

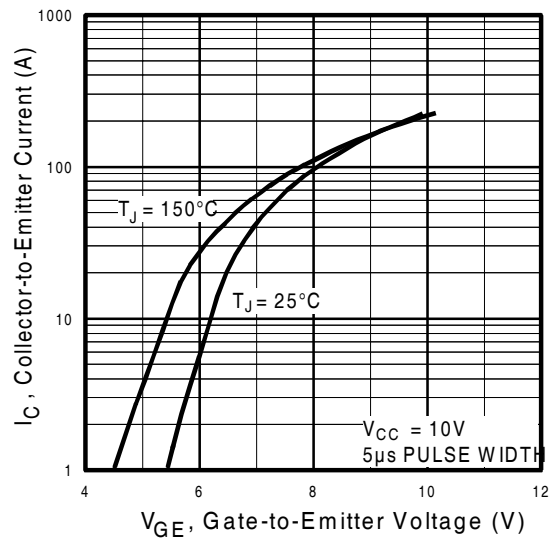
|                          | Parameter   | Min. | Typ. | Max. | Units | Conditions   |
|--------------------------|---|------|------|------|-------|--|
| Q <sub>g</sub>           | Total Gate Charge (turn-on)                               | ---- | 180  | 270  |       | I <sub>C</sub> = 27A   |
| Q <sub>ge</sub>          | Gate - Emitter Charge (turn-on)                           | ---- | 25   | 38   | nC    | V <sub>CC</sub> = 400V<br>See Fig. 8   |
| Q <sub>gc</sub>          | Gate - Collector Charge (turn-on)                         | ---- | 61   | 90   |       | V <sub>GE</sub> = 15V<br>T <sub>J</sub> = 25°C   |
| t <sub>d(on)</sub>       | Turn-On Delay Time  | ---- | 46   | ---- |       |  |
| t <sub>r</sub>           | Rise Time   | ---- | 25   | ---- | ns    | I <sub>C</sub> = 27A, V <sub>CC</sub> = 480V   |
| t <sub>d(off)</sub>      | Turn-Off Delay Time                                       | ---- | 140  | 230  |       | V <sub>GE</sub> = 15V, R <sub>G</sub> = 5.0Ω<br>Energy losses include "tail" and diode reverse recovery.<br>See Fig. 9, 10, 11, 18 |
| t <sub>f</sub>           | Fall Time   | ---- | 74   | 110  |       |  |
| E <sub>on</sub>          | Turn-On Switching Loss                                    | ---- | 0.99 | ---- |       |  |
| E <sub>off</sub>         | Turn-Off Switching Loss                                   | ---- | 0.59 | ---- | mJ    |  |
| E <sub>is</sub>          | Total Switching Loss                                      | ---- | 1.58 | 1.9  |       |  |
| t <sub>d(on)</sub>       | Turn-On Delay Time  | ---- | 44   | ---- |       | T <sub>J</sub> = 150°C, See Fig. 9, 10, 11, 18   |
| t <sub>r</sub>           | Rise Time   | ---- | 27   | ---- | ns    | I <sub>C</sub> = 27A, V <sub>CC</sub> = 480V   |
| t <sub>d(off)</sub>      | Turn-Off Delay Time                                       | ---- | 240  | ---- |       | V <sub>GE</sub> = 15V, R <sub>G</sub> = 5.0Ω<br>Energy losses include "tail" and diode reverse recovery.                           |
| t <sub>f</sub>           | Fall Time   | ---- | 130  | ---- |       | Measured 5mm from package  |
| E <sub>is</sub>          | Total Switching Loss                                      | ---- | 2.3  | ---- | mJ    | V <sub>GE</sub> = 0V   |
| L <sub>E</sub>           | Internal Emitter Inductance                               | ---- | 13   | ---- | nH    |  |
| C <sub>ies</sub>         | Input Capacitance   | ---- | 4000 | ---- |       |  |
| C <sub>oes</sub>         | Output Capacitance  | ---- | 250  | ---- | pF    | V <sub>CC</sub> = 30V<br>See Fig. 7  |
| C <sub>res</sub>         | Reverse Transfer Capacitance                              | ---- | 52   | ---- |       | f = 1.0MHz   |
| t <sub>rr</sub>          | Diode Reverse Recovery Time                               | ---- | 50   | 75   | ns    | T <sub>J</sub> = 25°C See Fig.<br>T <sub>J</sub> = 125°C 14 I <sub>F</sub> = 25A   |
| I <sub>rr</sub>          | Diode Peak Reverse Recovery Current                       | ---- | 4.5  | 10   | A     | T <sub>J</sub> = 25°C See Fig.   |
|                          |   | ---- | 8.0  | 15   |       | T <sub>J</sub> = 125°C 15  |
| Q <sub>rr</sub>          | Diode Reverse Recovery Charge                             | ---- | 112  | 375  | nC    | T <sub>J</sub> = 25°C See Fig.   |
|                          |   | ---- | 420  | 1200 |       | T <sub>J</sub> = 125°C 16  |
| di <sub>(rec)M</sub> /dt | Diode Peak Rate of Fall of Recovery During t <sub>h</sub> | ---- | 250  | ---- | A/μs  | T <sub>J</sub> = 25°C  |
|                          |   | ---- | 160  | ---- |       | T <sub>J</sub> = 125°C   |
|                          |   |      |      |      |       | V <sub>R</sub> = 200V<br>di/dt 200A/μs   |



**Fig. 1 - Typical Load Current vs. Frequency**  
 (Load Current =  $I_{\text{RMS}}$  of fundamental)

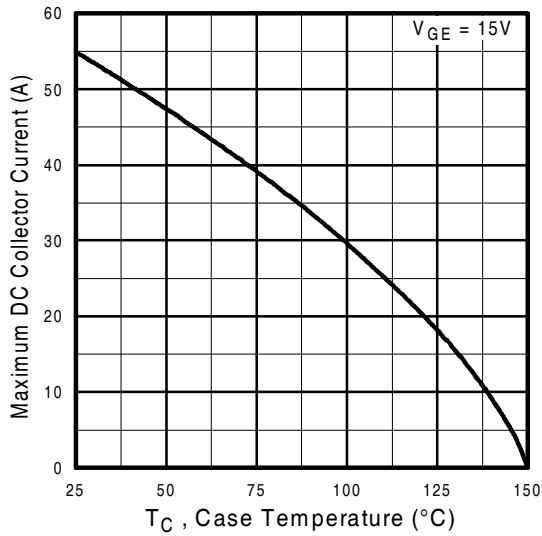


**Fig. 2 - Typical Output Characteristics**

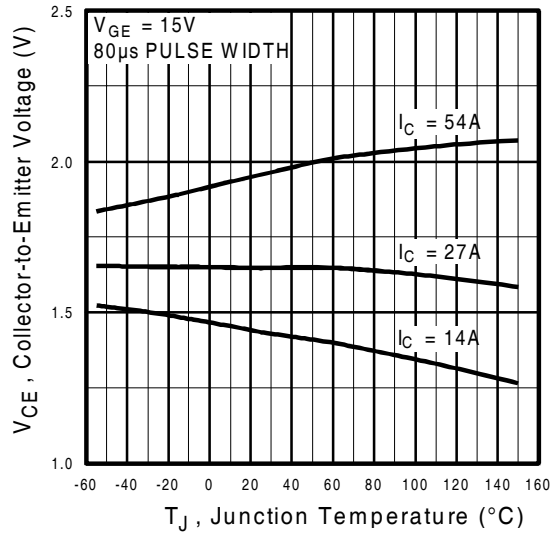


**Fig. 3 - Typical Transfer Characteristics**

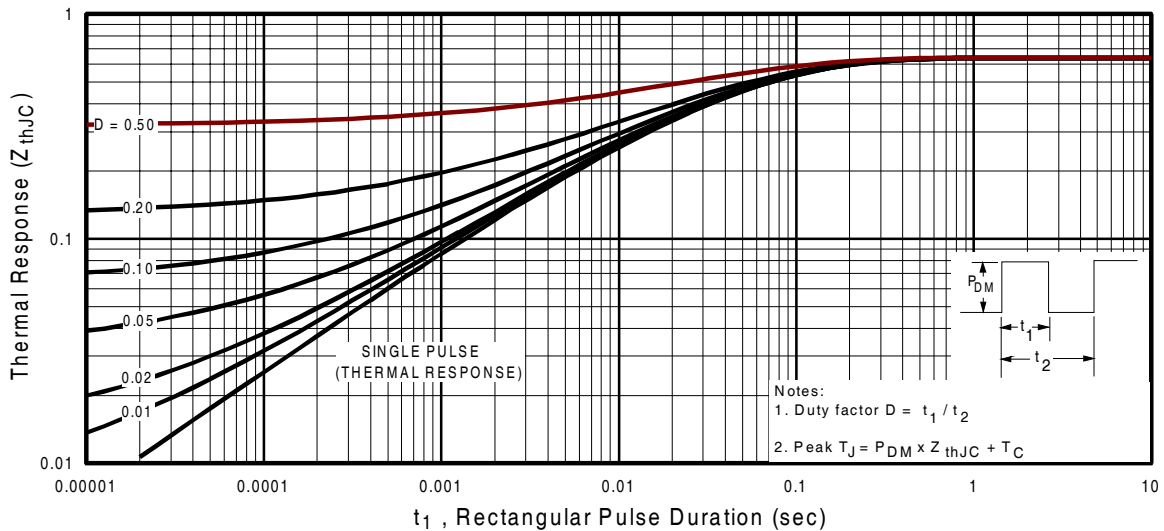
# IRG4PC50UDPbF



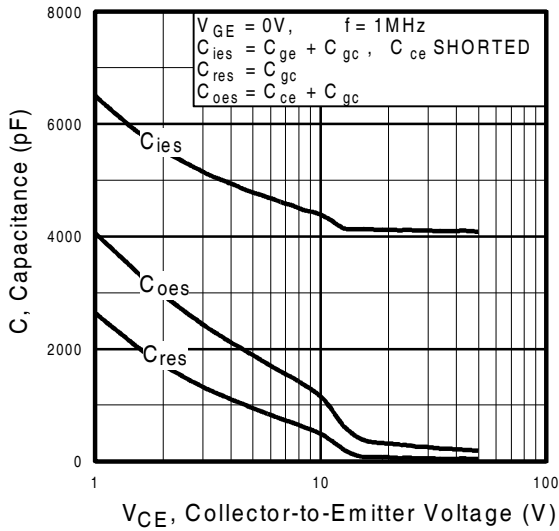
**Fig. 4** - Maximum Collector Current vs. Case Temperature



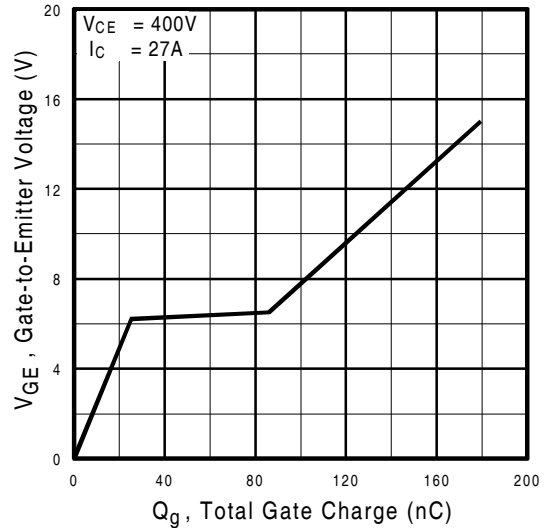
**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature



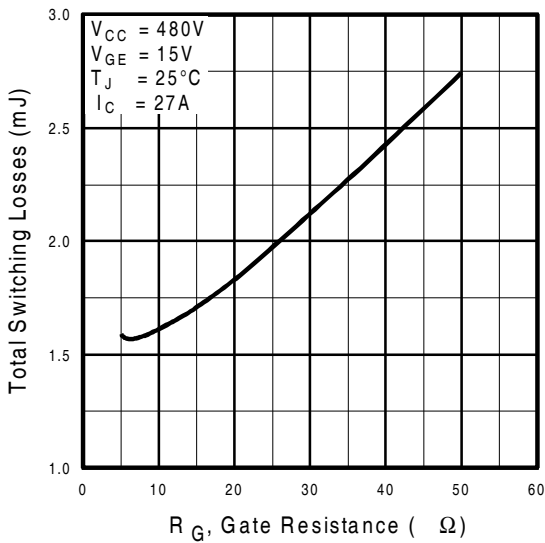
**Fig. 6** - Maximum IGBT Effective Transient Thermal Impedance, Junction-to-Case



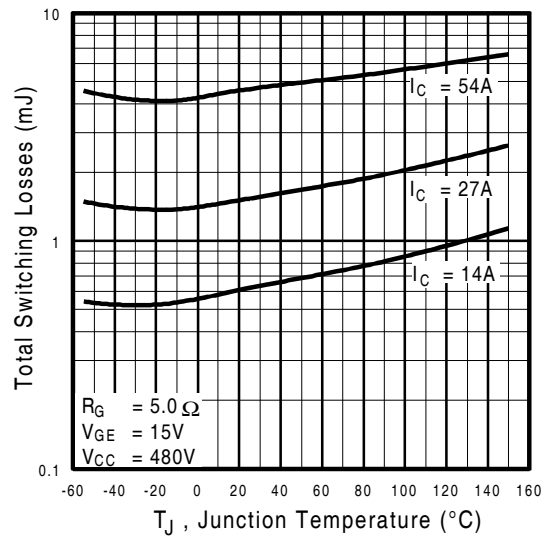
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage

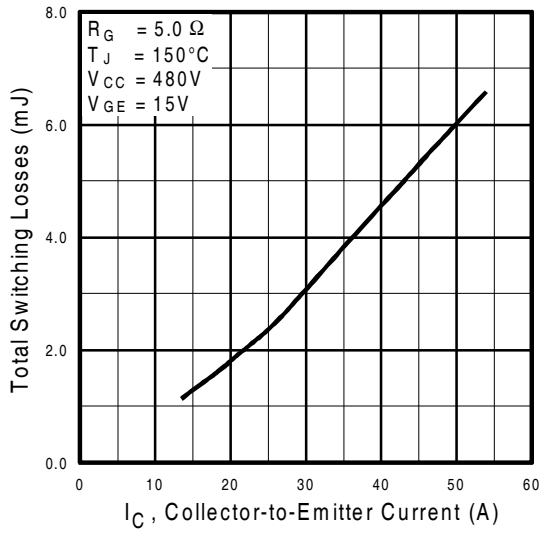


**Fig. 9** - Typical Switching Losses vs. Gate Resistance

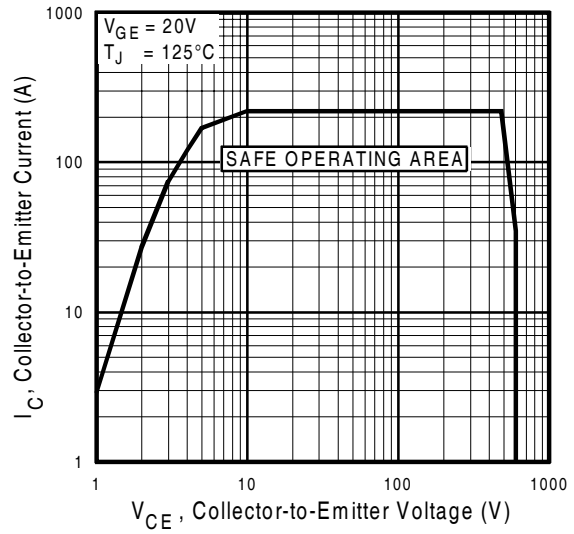


**Fig. 10** - Typical Switching Losses vs. Junction Temperature

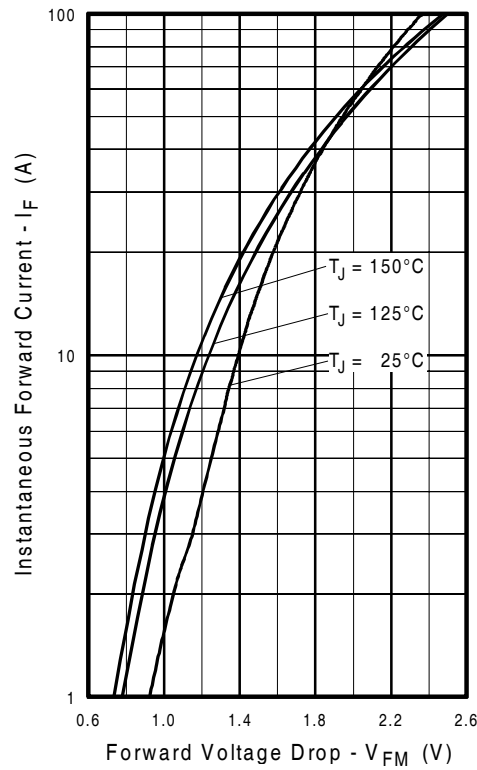
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**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



**Fig. 12** - Turn-Off SOA



**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

# IRG4PC50UDPbF

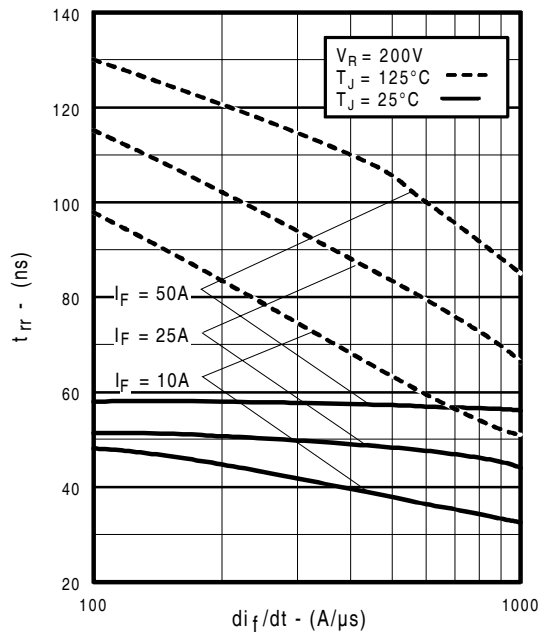


Fig. 14 - Typical Reverse Recovery vs.  $di_f/dt$

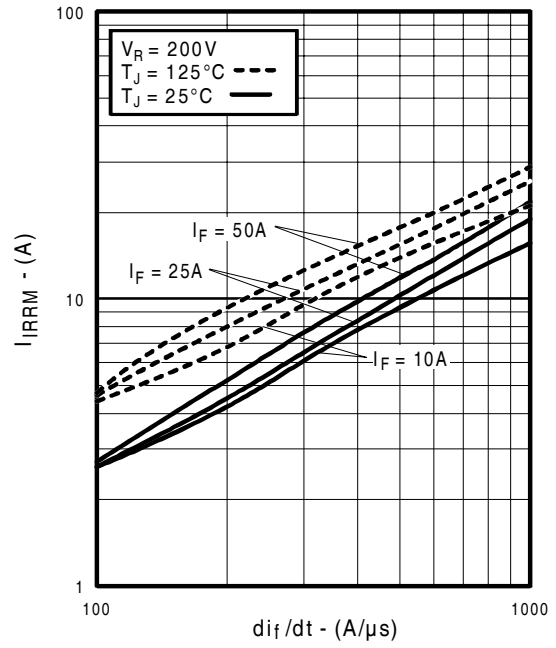


Fig. 15 - Typical Recovery Current vs.  $di_f/dt$

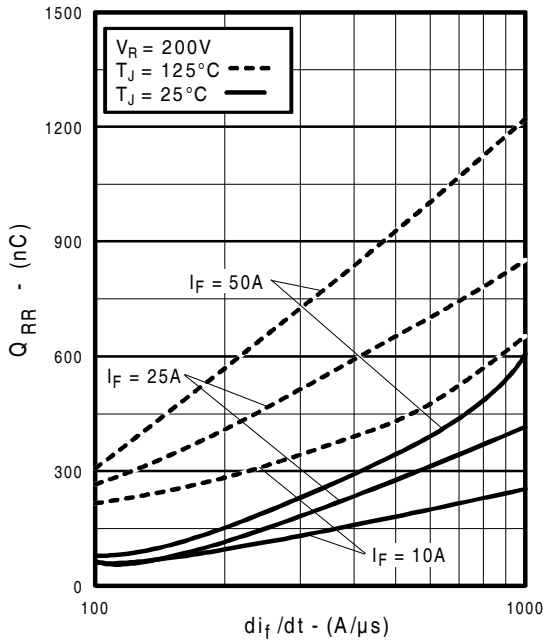


Fig. 16 - Typical Stored Charge vs.  $di_f/dt$

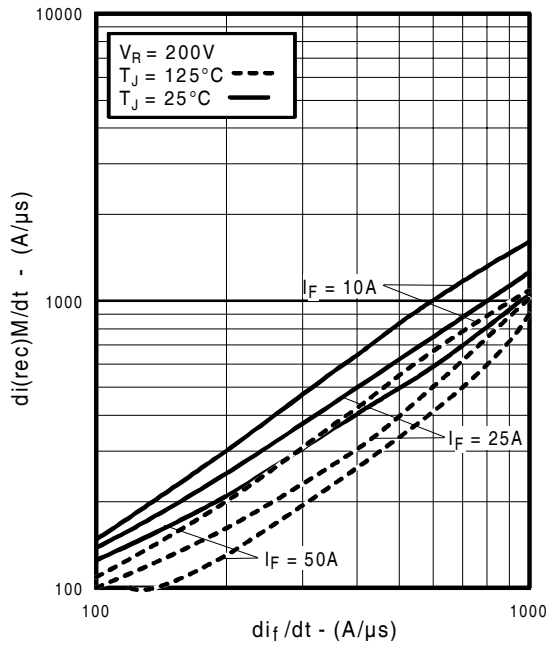
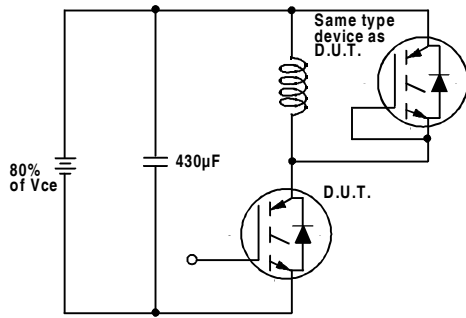
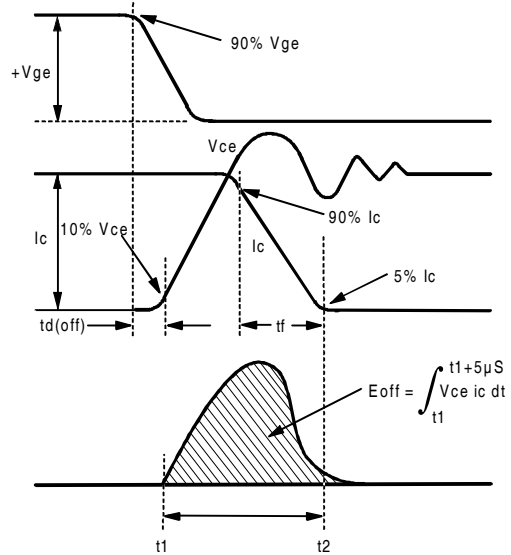


Fig. 17 - Typical  $di_{(rec)M}/dt$  vs.  $di_f/dt$

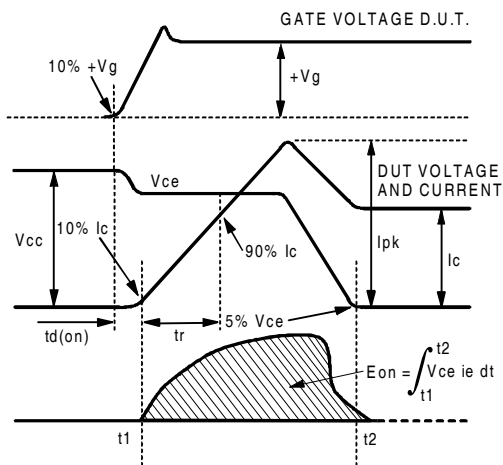
# IRG4PC50UDPbF



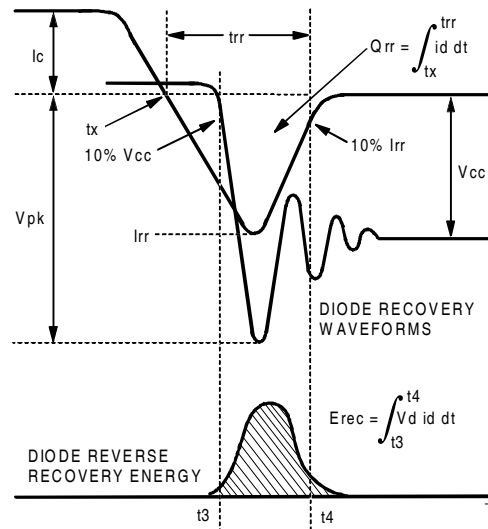
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$



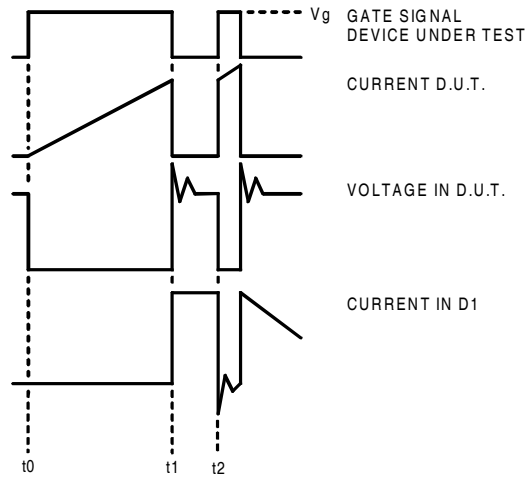


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

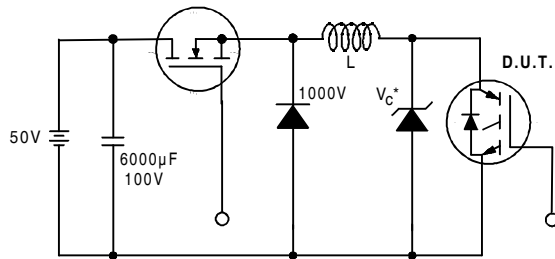


Figure 19. Clamped Inductive Load Test Circuit

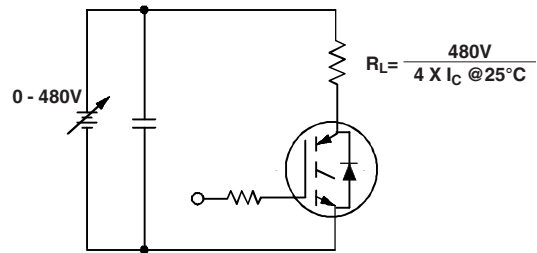


Figure 20. Pulsed Collector Current Test Circuit

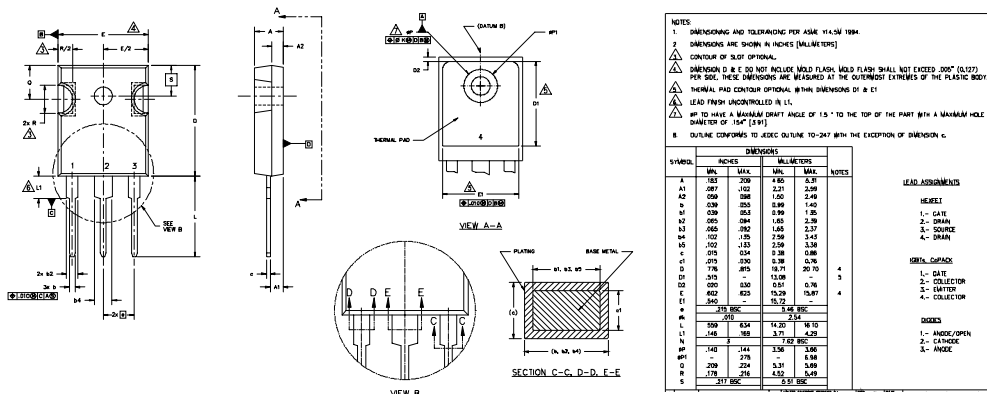
# IRG4PC50UDPbF

## Notes:

- ① Repetitive rating:  $V_{GE} = 20V$ ; pulse width limited by maximum junction temperature (figure 20)
- ②  $V_{CC} = 80\%(V_{CES})$ ,  $V_{GE} = 20V$ ,  $L = 10\mu H$ ,  $R_G = 5.0\Omega$  (figure 19)
- ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
- ④ Pulse width  $5.0\mu s$ , single shot.

## TO-247AC Package Outline

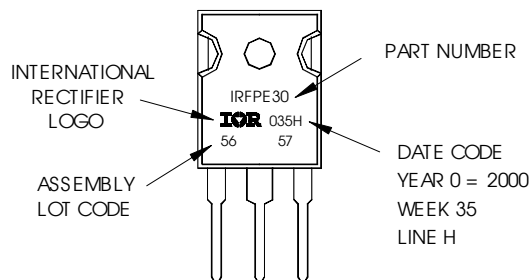
Dimensions are shown in millimeters (inches)



## TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30  
WITH ASSEMBLY  
LOT CODE 5657  
ASSEMBLED ON WW 35, 2000  
IN THE ASSEMBLY LINE "H"

**Note:** "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>